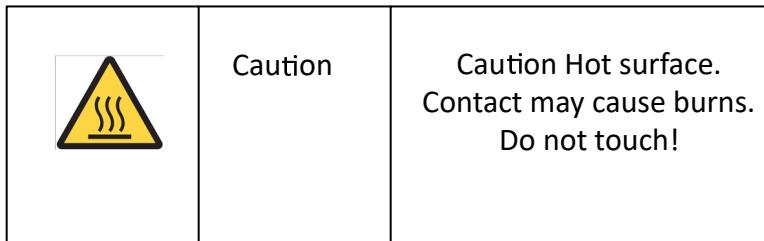


ABSTRACT

This user's guide describes the evaluation module (EVM) for the TPS2597xx eFuse. The TPS2597xx device is a 2.7-V to 23-V, 7-A eFuse with integrated 11-mΩ FET with overcurrent protection, inrush current protection, adjustable overcurrent transient blanking timer, and programmable undervoltage and overvoltage protection.

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Trademarks

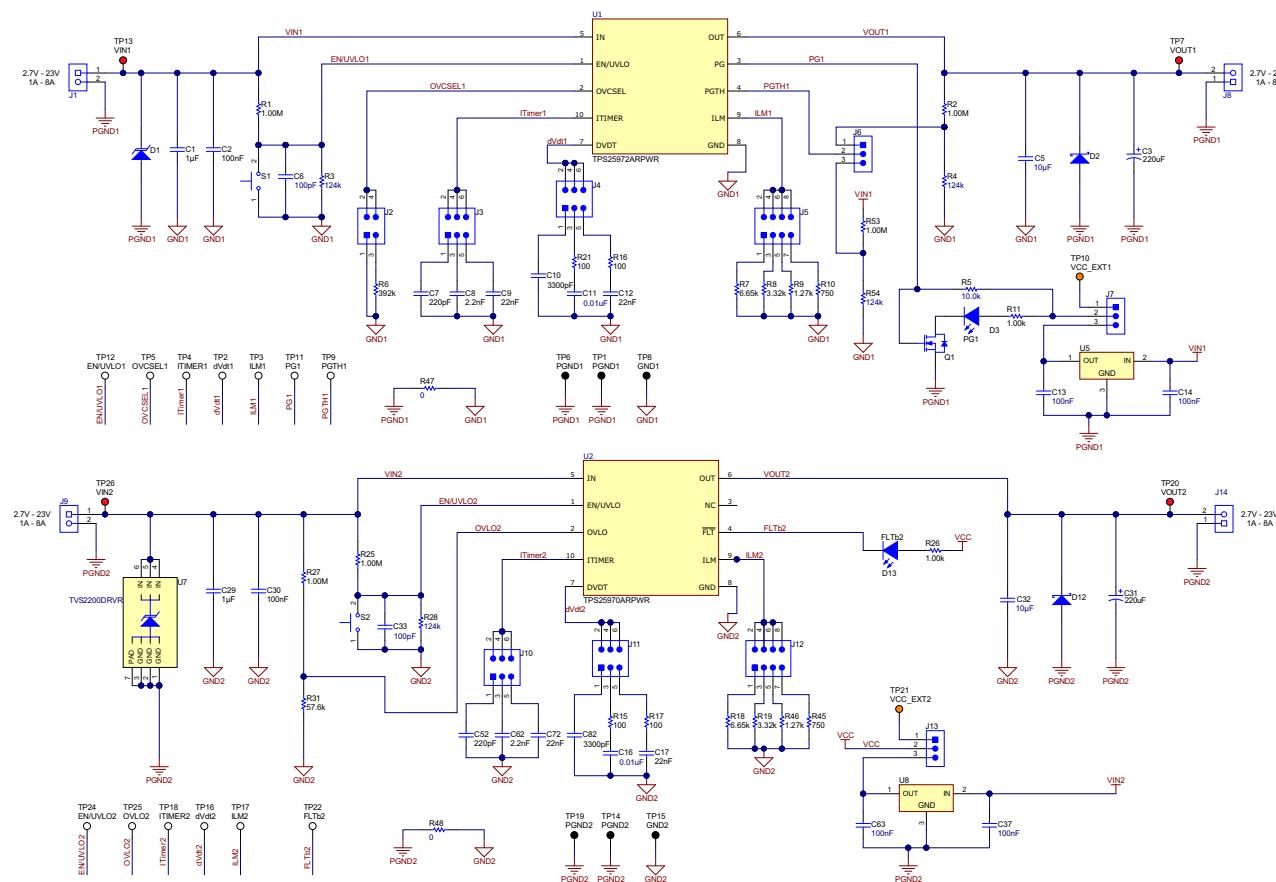
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Trademarks

All trademarks are the property of their respective owners.

3 Schematic

Figure 3-1 illustrates the EVM schematic.



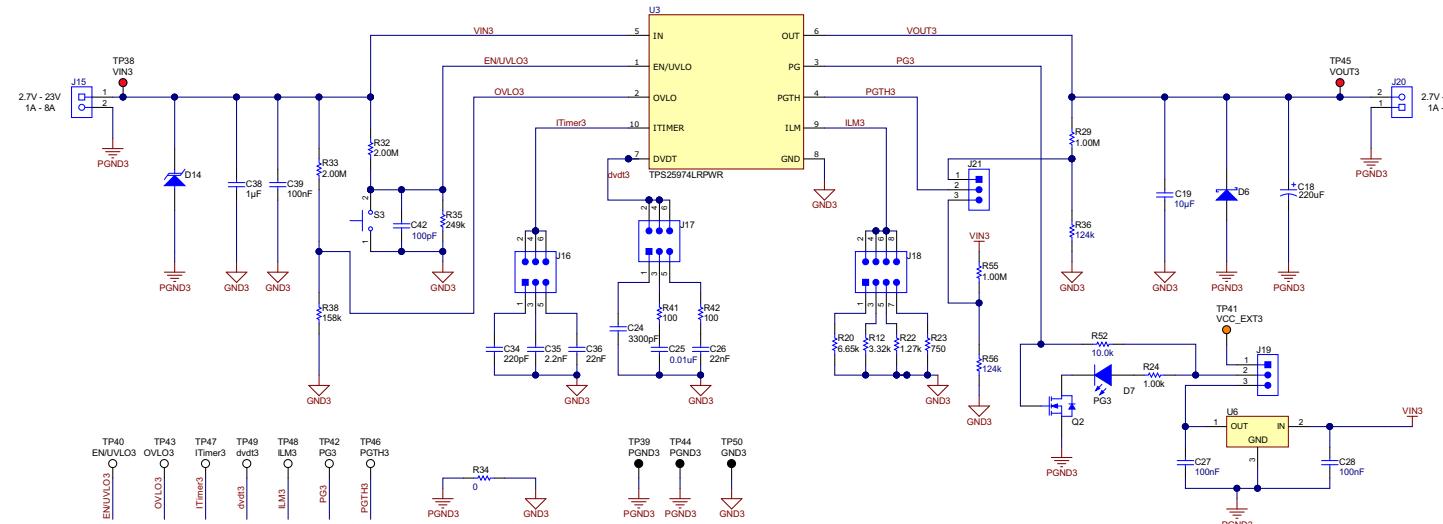


Figure 3-1. TPS2597EVM eFuse Evaluation Board Schematic

5 Test Setup and Procedures

In this user's guide, the test procedure is described for TPS25972A, TPS25974L, and TPS25970A devices. Following similar test steps, all other variants from TPS2597xx family can also be evaluated.

Make sure the evaluation board has default jumper settings as shown in [Table 5-1](#).

Table 5-1. Default Jumper Setting for TPS2597EVM eFuse Evaluation Board

J3	J4	J5	J2	J6	J7	J10	J13	J11	J12	J18	J17	J16	J19	J21
3-4	7-8	3-4	3-4	2-3	2-3	3-4	2-3	3-4	7-8	7-8	3-4	3-4	2-3	2-3

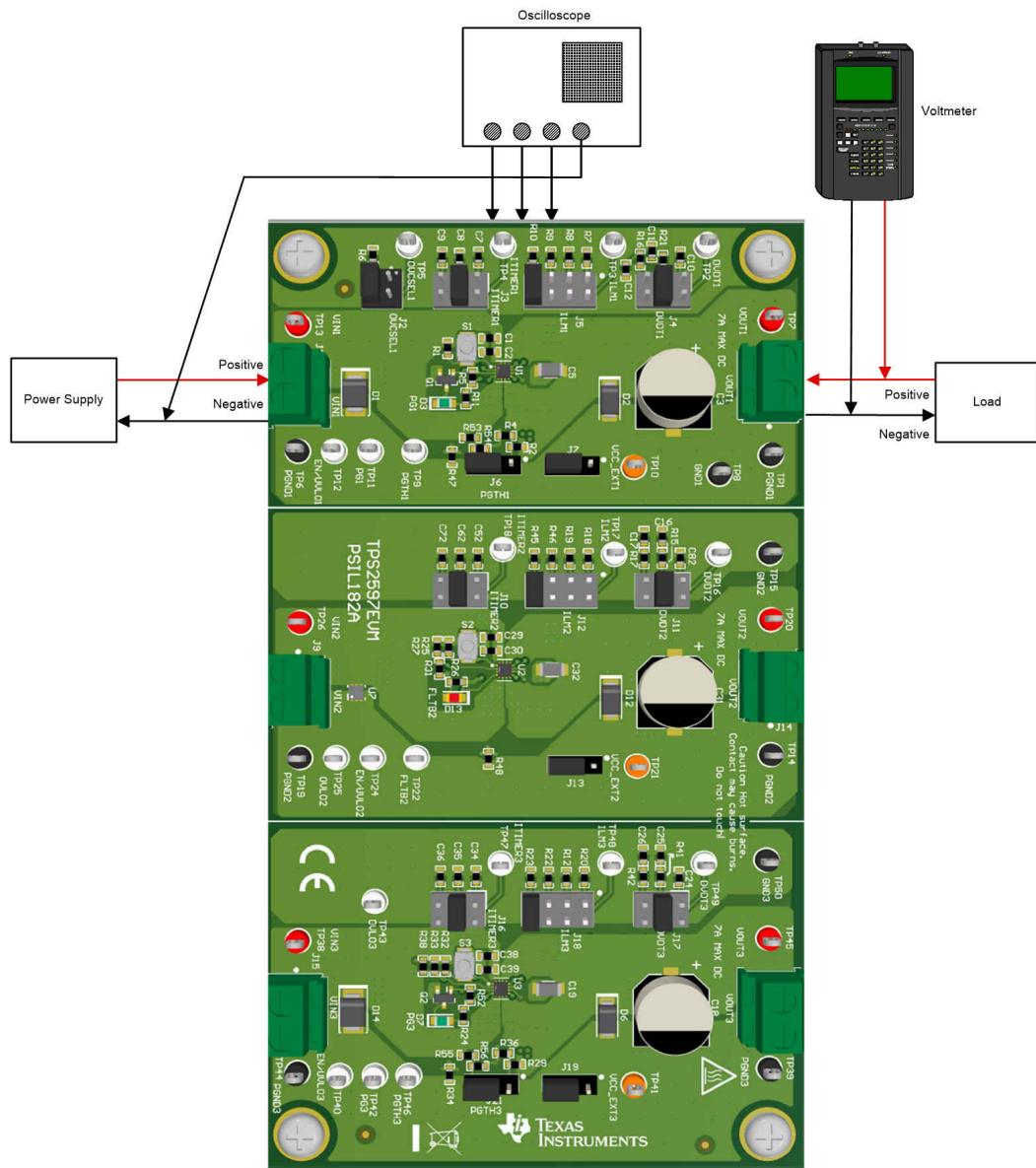


Figure 5-1. TPS2597EVM Setup With Test Equipment

Follow these instructions before starting any test and repeat again before moving to the next test:

- Set the power supply output (VIN) to zero volts.
- Turn ON the power supply and set the power supply output (VIN) to 12 V, current limit = 10 A.
- Turn OFF the power supply.
- Set the jumper setting on EVM to default position as shown in [Table 5-1](#).

5.1 Hot-Plug Test

Use the following instructions to measure the inrush current during the Hot-Plug event on channel 1:

1. Set Jumper J3 position to desired slew rate as mentioned in [Table 4-3](#).
2. Set the input supply voltage VIN to 12 V and current limit of 10 A. Enable the power supply.
3. Hot-plug the supply between VIN1 and PGND1 points of connector J1.
4. Observe the waveform at VOUT1 (TP7) and input current with an oscilloscope to measure the slew rate and rise time of the eFuse with a given input voltage of 12 V.

[Figure 5-2](#) shows an example of inrush current captured on the TPS2597EVM eFuse evaluation board.

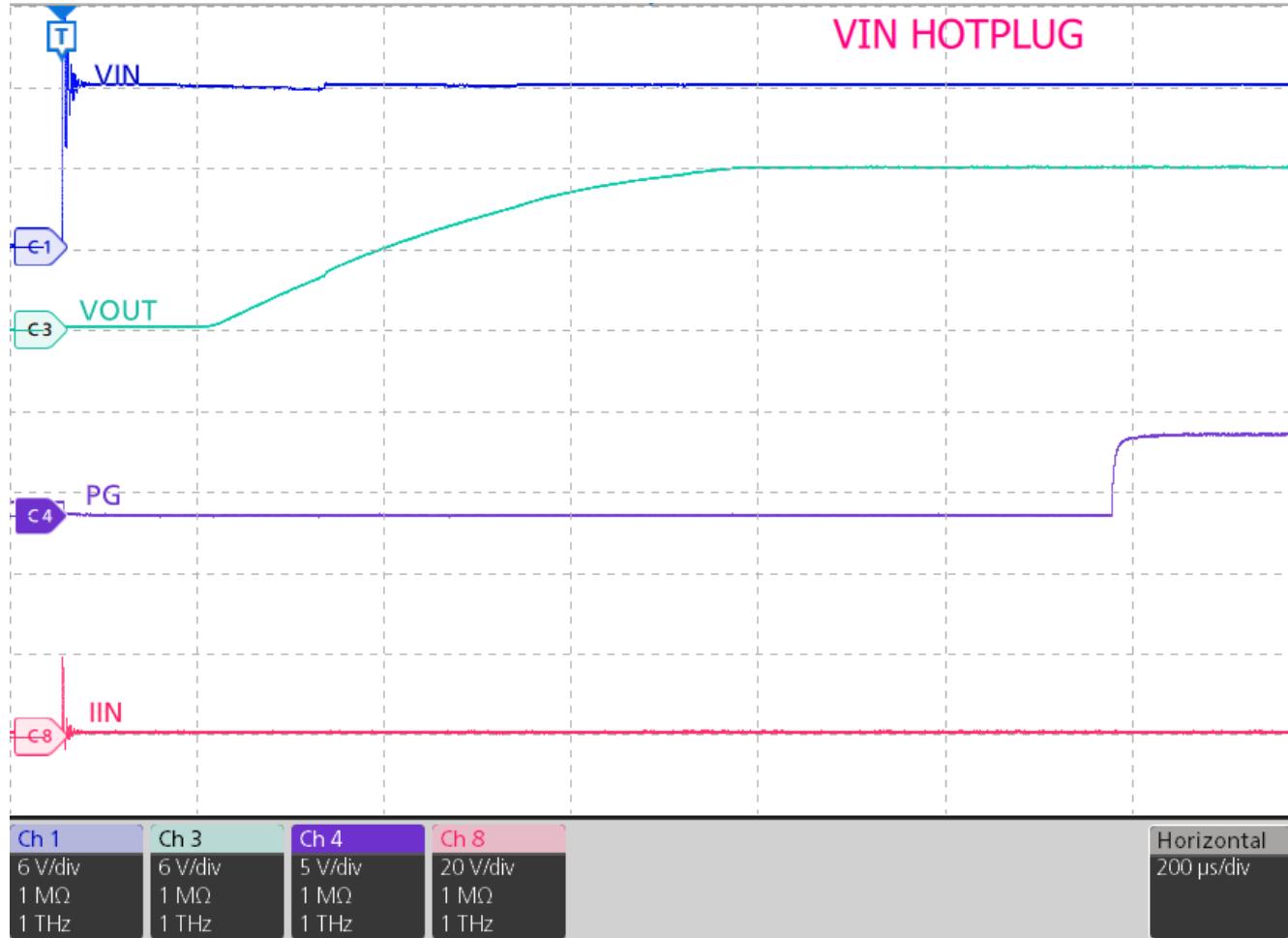


Figure 5-2. TPS2597xx Output Rise Profile (VIN = 12 V, Cout = 10 μ F, CdVdT = OPEN, RILM = 750 Ω, No Load)

5.2 Overcurrent Test

Use the following instructions to perform the overcurrent test on the circuit breaker variant (TPS25974x) of TPS2597xx eFuse:

1. Place jumper J16 to the appropriate position to obtain required blanking period as per [Table 4-3](#).
2. Set the input supply voltage VIN to 12 V and current limit of 10 A and enable the power supply.
3. Place jumper J18 in a suitable position to set the required current limit as per [Table 4-3](#).
4. Apply an overload greater than the set current limit between VOUT and GND (while testing the current limit variant of TPS2597xx, use a resistive load to apply overcurrent). CC load is not recommended for the current limit test.
5. The device allows the overload current for the programmed ITIMER period and then switches OFF.

[Figure 5-3](#) shows an example of the circuit breaker test on the TPS2597EVM.

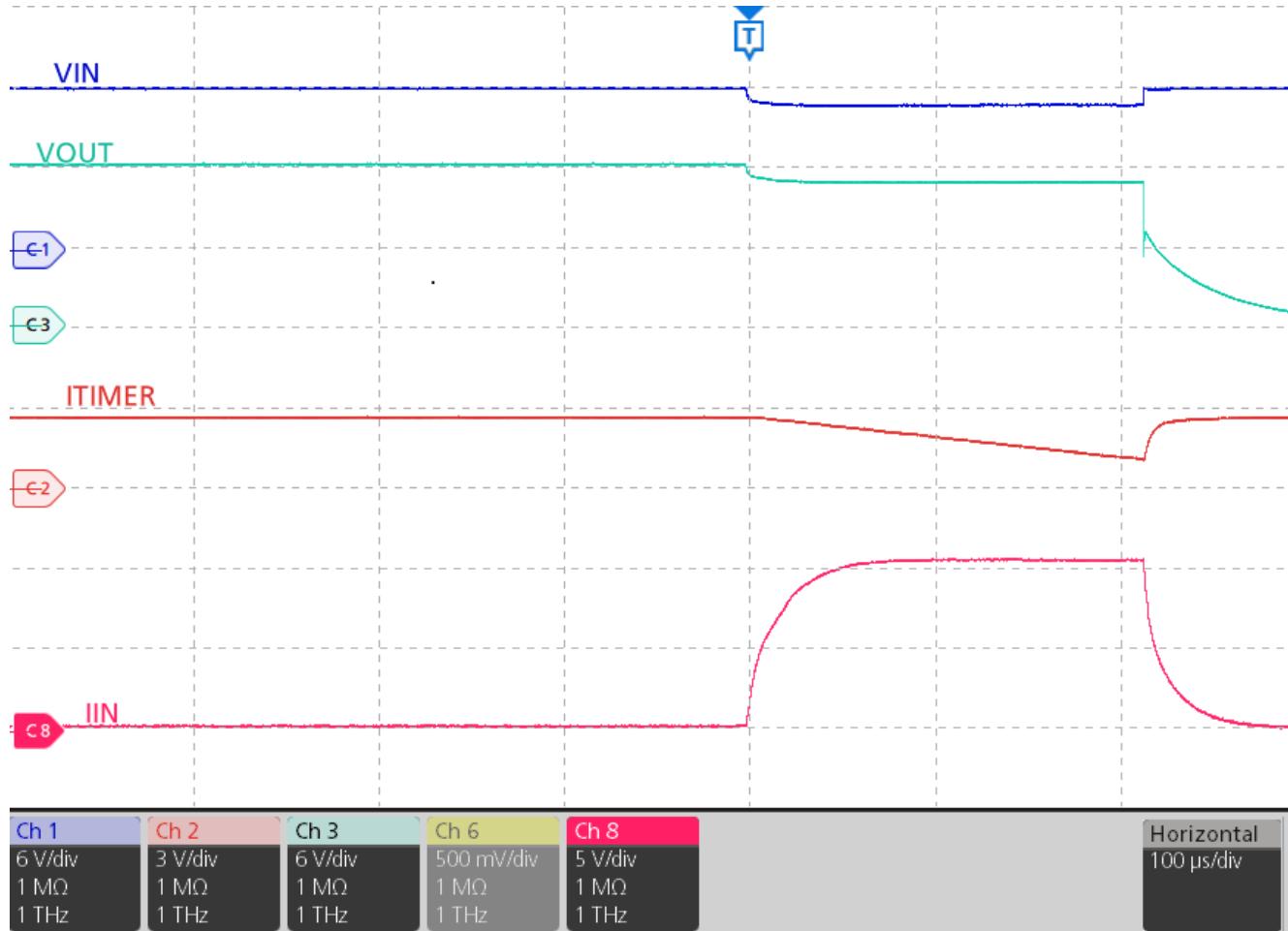


Figure 5-3. Overcurrent Response of TPS25974x for 8-A Current Limit Setting

5.3 Output Hot-Short Test

Use the following instructions to perform the output Hot-Short test:

1. Set the input supply voltage VIN to 12 V and current limit of 10 A. Turn ON the power supply.
2. Short the output of the device. For example, VOUT to GND with a shorter cable.
3. Observe the waveforms using an oscilloscope.

Figure 5-4 shows test waveform of output hot-short on the TPS2597EVM eFuse evaluation board.

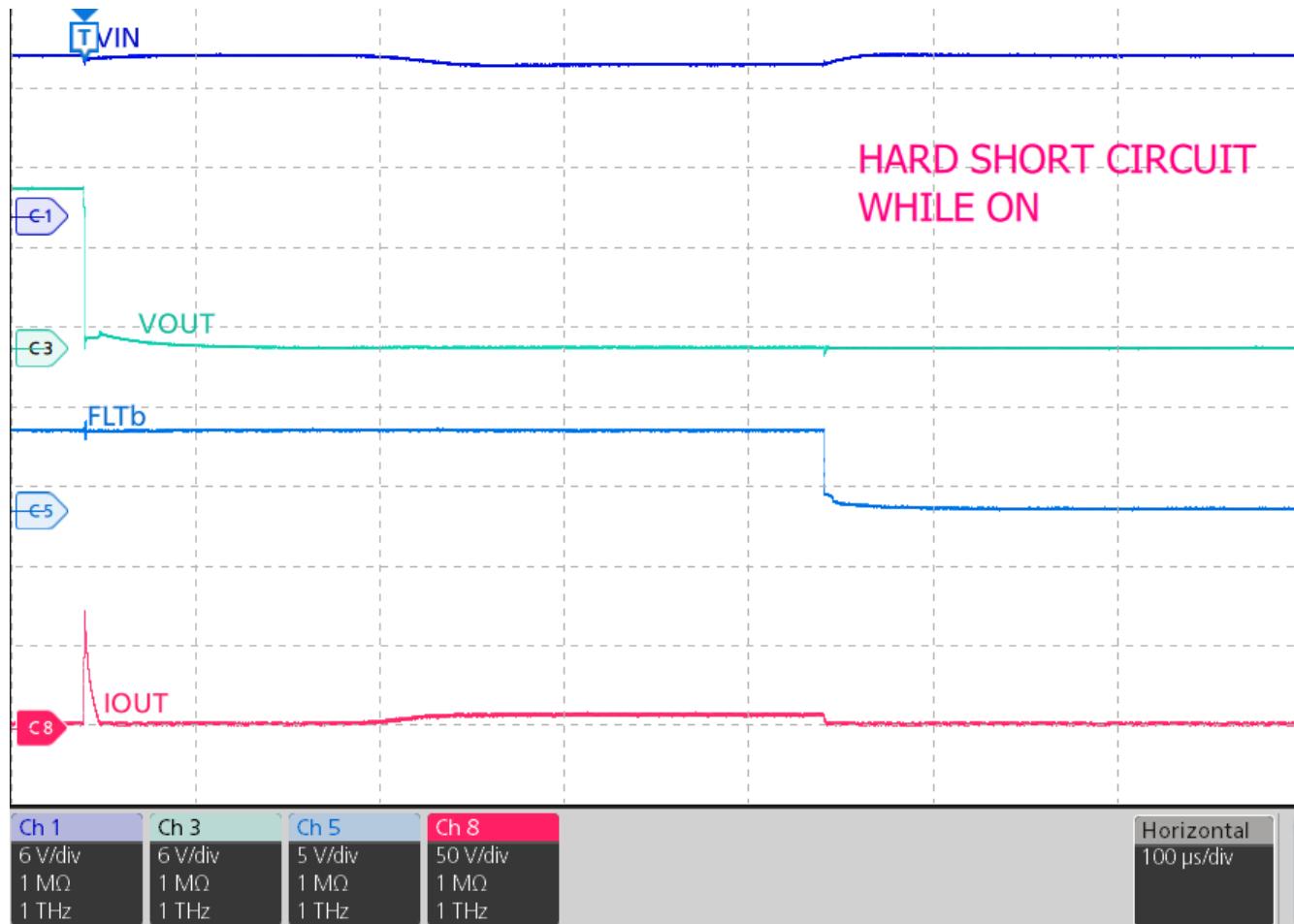


Figure 5-4. Output Hot-Short Response of TPS2597xx Device at Vin = 12 V, Cout = Open, R_{ILM} = 750 Ω

5.4 Wakeup into Short Test

Use the following instructions to perform the wakeup into short test:

1. Set the input supply voltage VIN to 12 V and current limit of 10 A. Turn OFF the power supply.
2. Short the output of the device for example, VOUT to GND with a shorter cable.
3. Turn ON the power supply.

Figure 5-5 shows test waveform of wakeup into output short on the TPS2597EVM eFuse evaluation board.

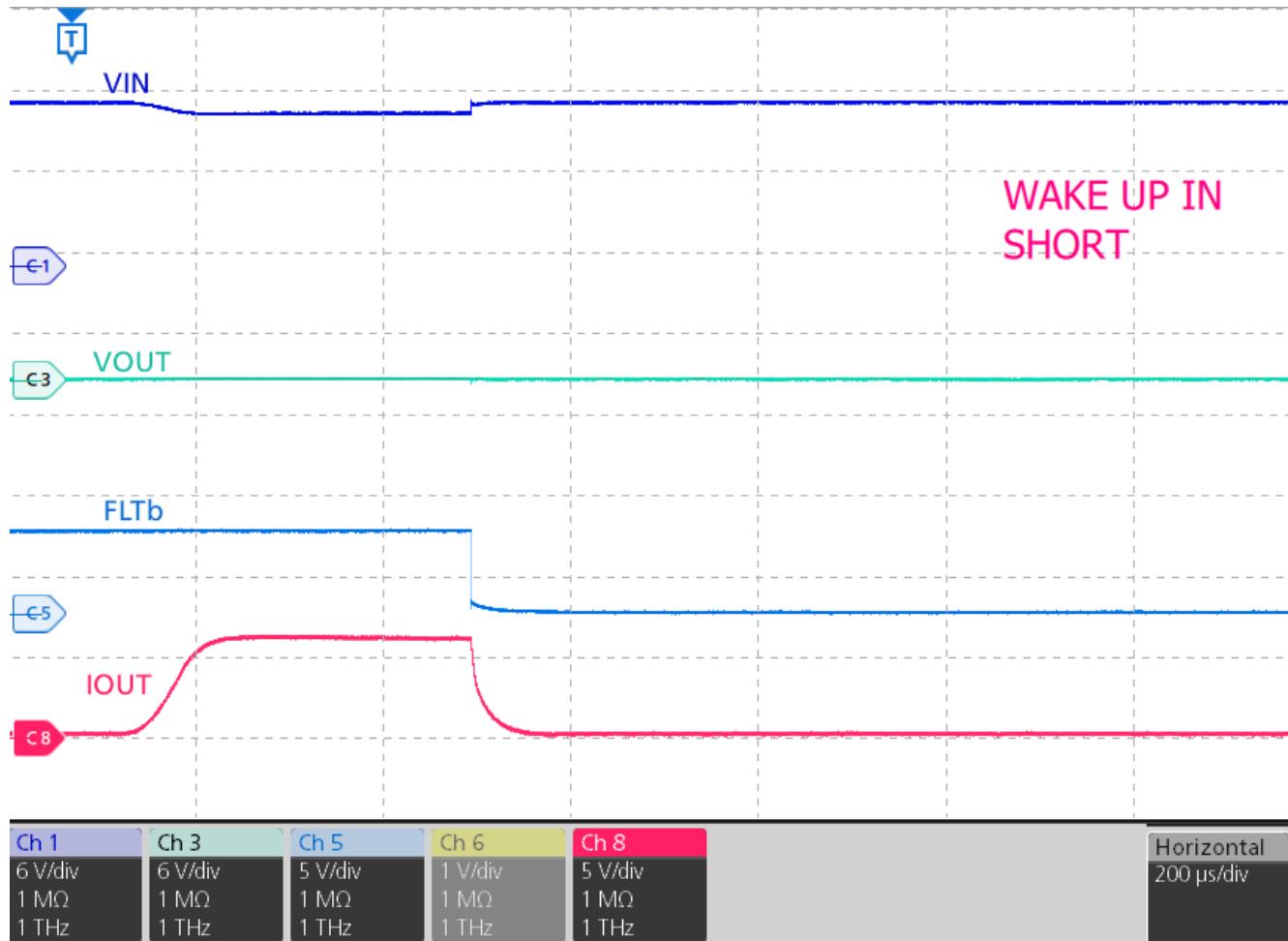


Figure 5-5. Test Waveform of Wakeup into Output Short for TPS2597xx Device at Vin = 12 V, Cout = Open, R_{ILM} = 750 Ω

5.5 Overvoltage Clamp Test

Use the following instructions to perform the overvoltage protection test on channel 1:

1. Remove input TVS diodes.
2. Set the input supply voltage VIN to 12 V and current limit of 10 A. Apply the supply between VIN1 and PGND1 at connector J1 and enable the power supply.
3. Increase the input supply VIN from 12 V to 16 V and observe the waveforms using an oscilloscope.

Figure 5-6 shows overvoltage response of TPS25972x on the TPS2597EVM eFuse evaluation board.

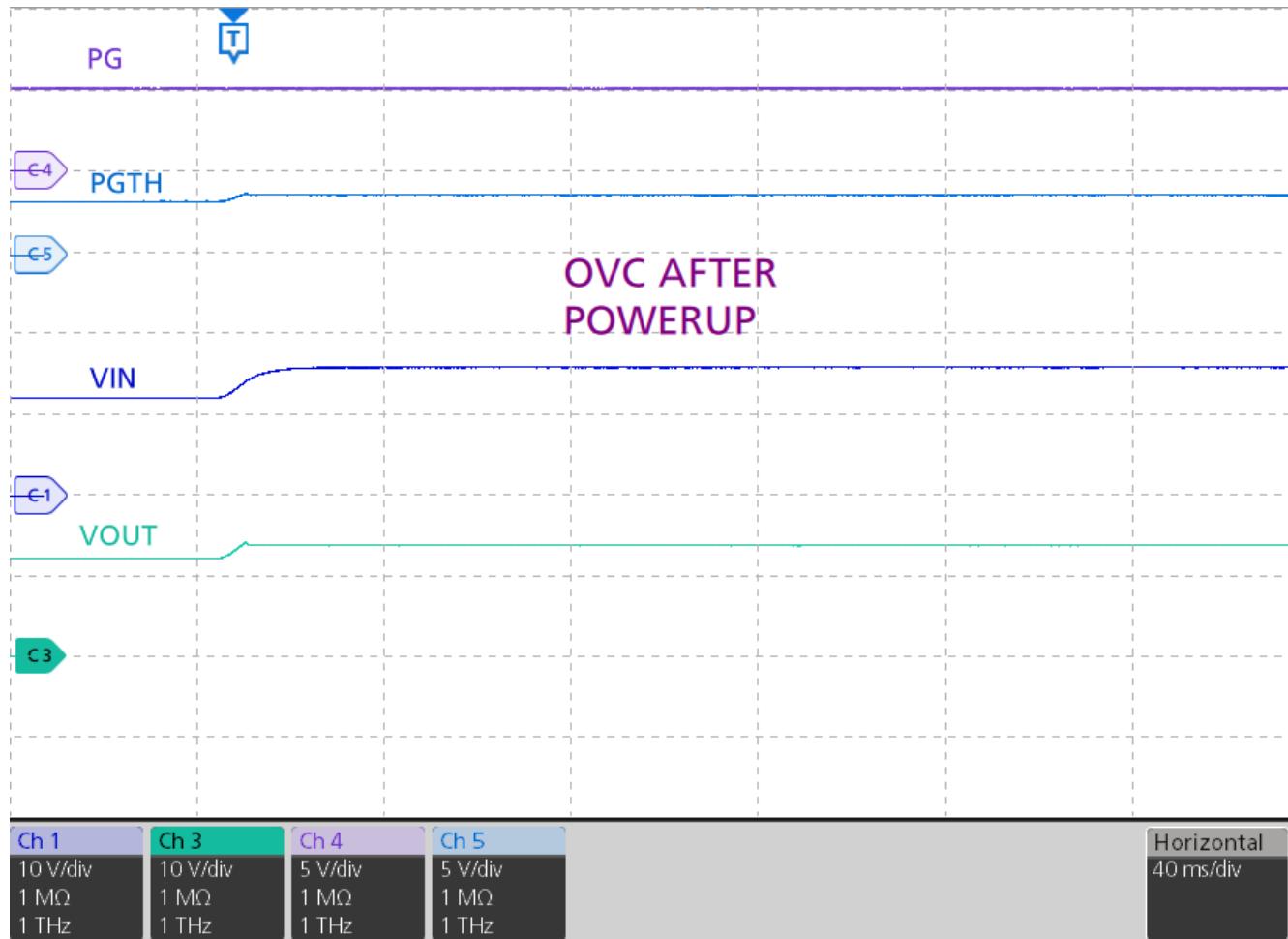


Figure 5-6. Overvoltage Protection Response of the TPS25972x Device

6 EVAL Board Assembly Drawings and Layout Guidelines

6.1 PCB Drawings

Figure 6-1 shows component placement of the EVAL Board. Figure 6-2 shows PCB layout images.

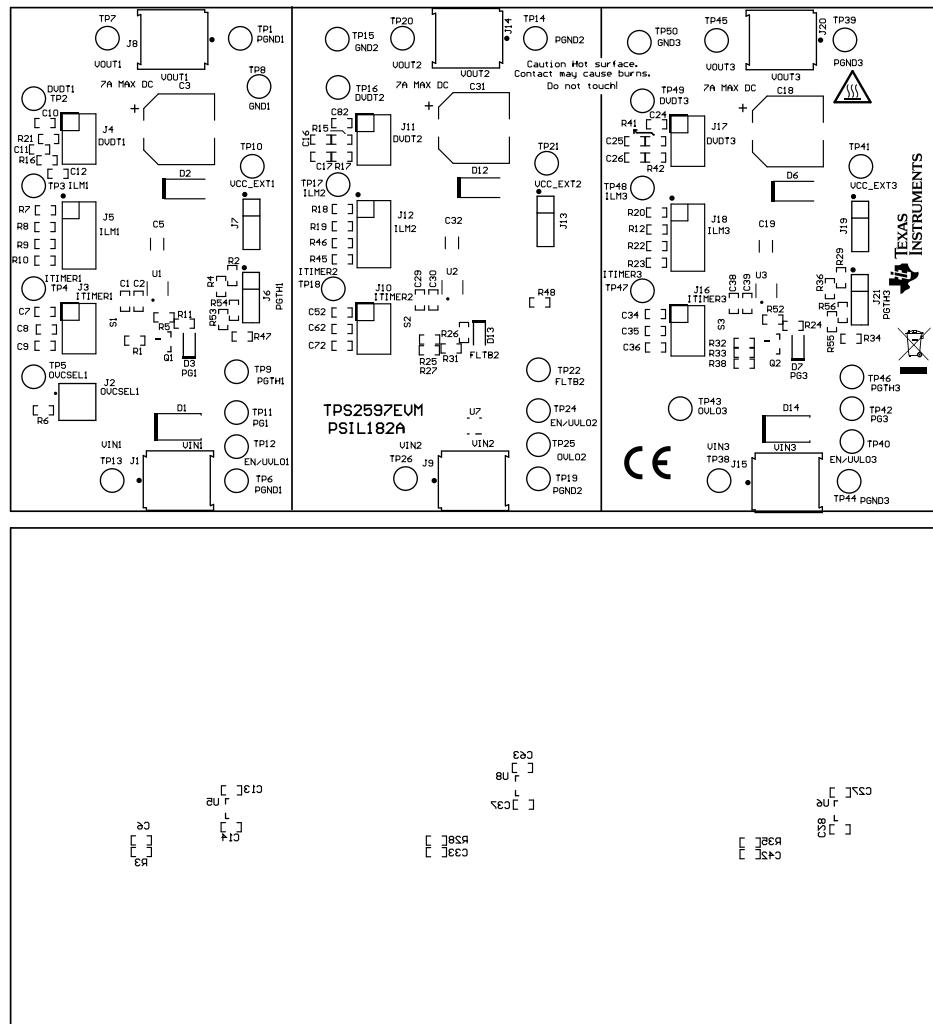
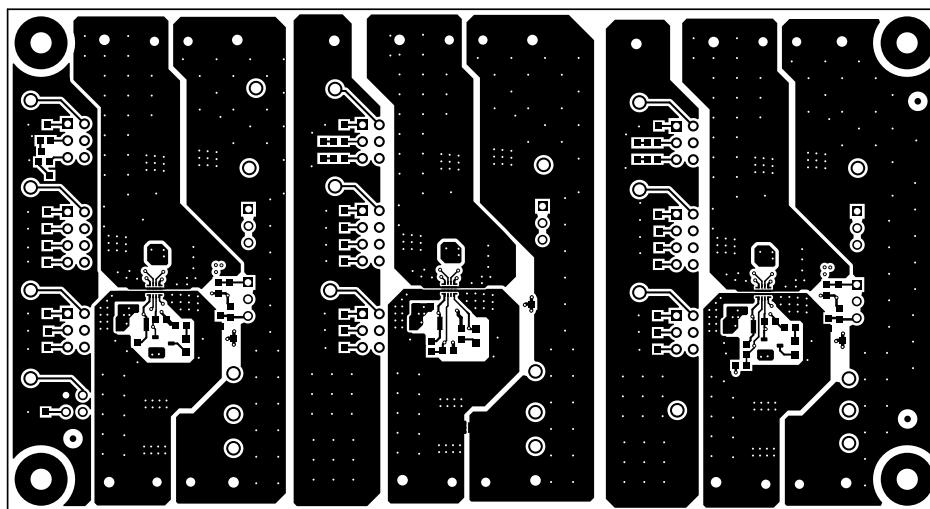


Figure 6-1. TPS2597EVM Board (a) Top Assembly (b) Bottom Assembly



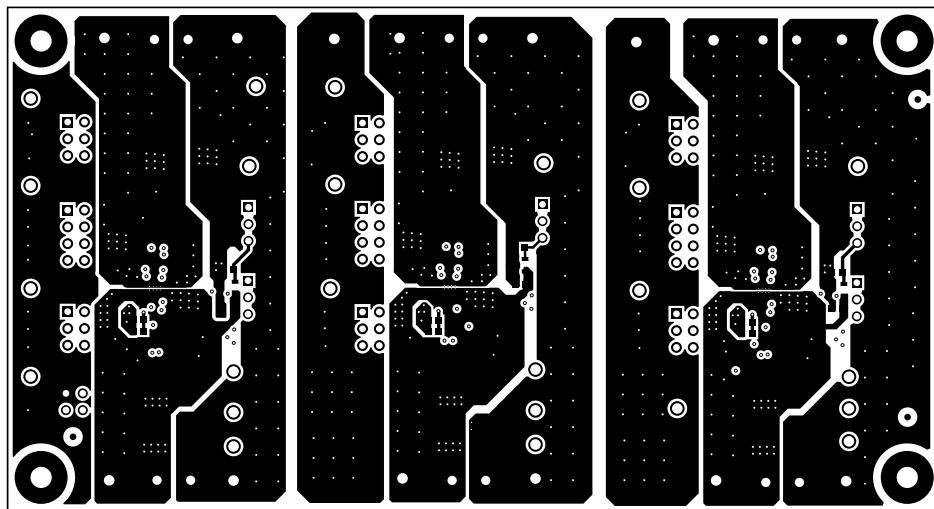


Figure 6-2. TPS2597EVM Board (a) Top Layer (b) Bottom Layer

Table 7-1. Bill of Materials (continued)

Designator	Quantity	Value	Description	Package Reference	Part Number	Manufacturer	Alternate Manufacturer ⁽¹⁾
TP1, TP6, TP8, TP14, TP15, TP19, TP39, TP44, TP50	9		Test Point, Multipurpose, Black, TH	Black Multipurpose Testpoint	5011	Keystone	
TP2, TP3, TP4, TP5, TP9, TP11, TP12, TP16, TP17, TP18, TP22, TP24, TP25, TP40, TP42, TP43, TP46, TP47, TP48, TP49	20		Test Point, Multipurpose, White, TH	White Multipurpose Testpoint	5012	Keystone	
TP7, TP13, TP20, TP26, TP38, TP45	6		Test Point, Multipurpose, Red, TH	Red Multipurpose Testpoint	5010	Keystone	
TP10, TP21, TP41	3		Test Point, Multipurpose, Orange, TH	Orange Multipurpose Testpoint	5013	Keystone	
U1	1		2.7- 23V, 7 A, 10 mΩ eFuse with accurate current monitor and transient fault management	VQFN-HR9	TPS25972ARPWR	Texas Instruments	
U2	1		2.7- 23V, 7 A, 10 mΩ eFuse with accurate current monitor and transient fault management	VQFN-HR9	TPS25970ARPWR	Texas Instruments	
U3	1		2.7- 23V, 7 A, 10 mΩ eFuse with accurate current monitor and transient fault management	VQFN-HR9	TPS25974LRPWR	Texas Instruments	
U5, U6, U8	3		100 mA, Quasi Low-Dropout Linear Voltage Regulator, 3-pin SOT-23, Pb-Free	DBZ0003A	LM3480IM3-3.3/NOPB	Texas Instruments	
U7	1		22-V Precision Surge Protection Clamp, DRV0006A (WSON-6)	DRV0006A	TVS2200DRV	Texas Instruments	Texas Instruments

(1) Unless otherwise noted in the Alternate Manufacturer column, all parts can be substituted with equivalents.

8 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision * (October 2021) to Revision A (December 2021)	Page
• Changed TPS25970L to TPS25970A throughout the document.....	1
• Updated the current limit settings in Table 2-1	3
• Updated the output slew rate value in Table 2-1	3
• Updated the ITimer value in Table 2-1	3
• Updated Figure 3-1	4
• Updated Figure 5-1	9
• Updated Figure 6-1 and Figure 6-2	15
• Updated the Bill of Materials	17

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